



XTMF90N06F

900V N-ch Planar MOSFET

Product Description

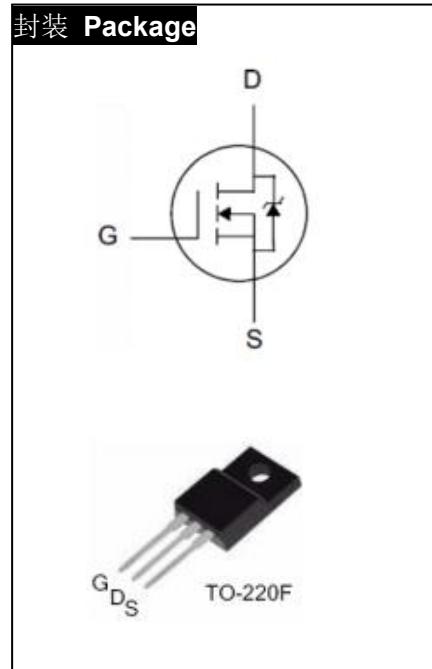
| | | |
|--------------------------|-----|---|
| BV _{DSS} | 900 | V |
| I _D | 6 | A |
| R _{DS(ON),Typ.} | 1.4 | Ω |

General Features

- RoHS Compliant
- R_{DS(ON),typ.}=1.4Ω@V_{GS}=10V
- Fast Recovery Body Diode
- Low Gate Charge Minimize Switching Loss

Applications

- Adaptor
- Charger
- SMPS Standby Power



Absolute Maximum Ratings T_j=25°C

| Symbol | Parameter | XTMF90N06F | Unit |
|----------------------------------|--|------------|----------|
| V _{DSS} | Drain-to-Source Voltage | 900 | V |
| V _{GSS} | Gate-to-Source Voltage | ±30 | |
| I _D | Continuous Drain Current | 6 | A |
| I _{DM} | Pulsed Drain Current at V _{GS} =10V | 24 | |
| E _{AS} | Single Pulse Avalanche Energy | 700 | mJ |
| P _D | Power Dissipation | 45 | W |
| | Derating Factor above 25°C | 0.29 | W/ °C |
| T _L | Soldering Temperature Distance of 1.6mm from case for 10 seconds | 300 | °C |
| T _J &T _{STG} | Operating and Storage Temperature Range | -55 to 150 | |



Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

| Symbol | Parameter | XTMF90N06F | | Unit |
|-----------------|--|------------|--|------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | 2.78 | | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | 100 | | °C/W |

Electrical Characteristics $T_j=25^\circ C$

OFF Characteristics

| Symbol | Parameter | Min | Typ | Max | Unit | Test Condition |
|------------|--------------------------------------|-----|-----|------|------|---|
| BV_{DSS} | Drain-to-Source Breakdown Voltage | 900 | - | - | V | $V_{GS}=0V, I_D=250\mu A$ |
| I_{DSS} | Drain-to-Source Leakage Current | - | - | 1 | uA | $V_{DS}=900V, V_{GS}=0V$ |
| | | - | - | 100 | | $V_{DS}=720V,$ $V_{GS}=0V,$ $T_J = 125^\circ C$ |
| I_{GSS} | Gate-to-Source Leakage Current | - | - | +100 | nA | $V_{GS}=+30V, V_{DS}=0V$ |
| | | - | - | -100 | | $V_{GS}=-30V, V_{DS}=0V$ |

ON Characteristics

| Symbol | Parameter | Min | Typ | Max | Unit | Test Condition |
|--------------|---|-----|-----|-----|------|-------------------------------------|
| $R_{DS(ON)}$ | Static Drain-to-Source On-Resistance | -- | 1.4 | 1.9 | Ω | $V_{GS}=10V, I_D=3A$ |
| $V_{GS(TH)}$ | Gate Threshold Voltage | 3.0 | -- | 5.0 | V | $V_{DS}=V_{GS}$, $I_D=250\mu A$ |
| g_{fs} | Forward Transconductance | -- | 8.0 | -- | S | $V_{DS}=15V, ID=3A$ |

**Dynamic Characteristics**

| Symbol | Parameter | Min | Typ | Max | Unit | Test Condition |
|-----------|-------------------------------|-----|------|-----|------|---|
| C_{iss} | Input Capacitance | .. | 1460 | .. | pF | $V_{GS}=0V$, $V_{DS}=25V$, $f=1.0MHz$ |
| C_{rss} | Reverse Transfer Capacitance | .. | 23 | .. | | |
| C_{oss} | Output Capacitance | .. | 130 | .. | | |
| Q_g | Total Gate Charge | .. | 37 | .. | nC | $V_{DD}=450V$, $I_D=6A$, $V_{GS}=0$ to 10V |
| Q_{gs} | Gate-to-Source Charge | .. | 8.0 | .. | | |
| Q_{gd} | Gate-to-Drain (Miller) Charge | .. | 14 | .. | | |

Resistive Switching Characteristics

| Symbol | Parameter | Min | Typ | Max | Unit | Test Condition |
|--------------|---------------------|-----|-----|-----|------|---|
| $t_{d(on)}$ | Turn-on Delay Time | .. | 22 | .. | nS | $V_{DD}=450V$, $I_D=6A$, $V_{GS}=10V$ $Rg=9.1\Omega$ |
| t_{rise} | Rise Time | .. | 45 | .. | | |
| $t_{d(off)}$ | Turn-Off Delay Time | .. | 33 | .. | | |
| t_{fall} | Fall Time | .. | 37 | .. | | |

Source-Drain Body Diode Characteristics

| Symbol | Parameter | Min | Typ | Max | Unit | Test Condition |
|----------|--|-----|-----|-----|------|---|
| I_{SD} | Continuous Source Current ^[1] | -- | -- | 6 | A | Integral pn-diode in MOSFET |
| I_{SM} | Pulsed Source Current ^[1] | -- | -- | 24 | | |
| V_{SD} | Diode Forward Voltage | -- | -- | 1.5 | V | $I_S=6A$, $V_{GS}=0V$ $V_{GS}=0V$ $di/dt=100A/\mu s$ |
| t_{rr} | Reverse Recovery Time | -- | 390 | -- | | |
| Q_{rr} | Reverse Recovery Charge | -- | 1.4 | -- | uC | |

[1] Pulse width $\leq 380\mu s$; duty cycle $\leq 2\%$



Typical Characteristics

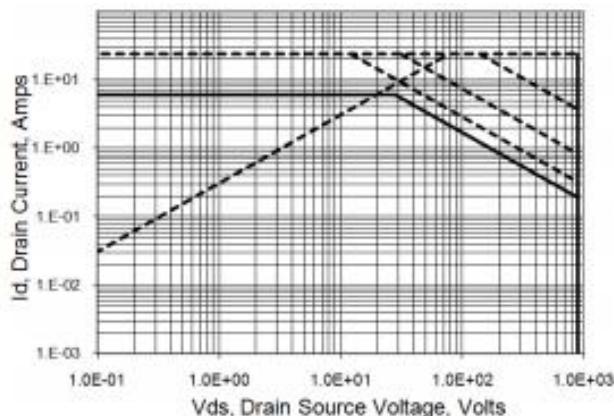


Figure 1 . Maximum Safe Operating Area

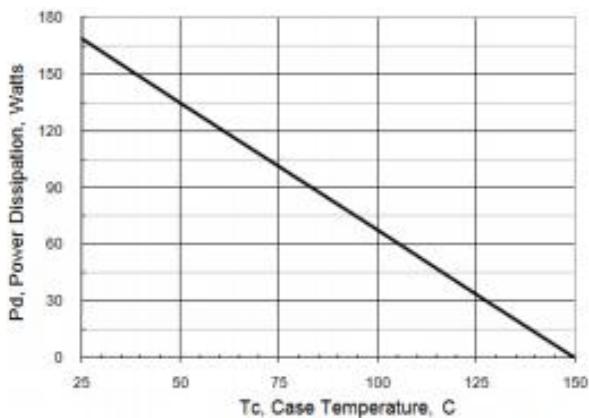


Figure 2 . Maximum Power Dissipation vs Case Temperature

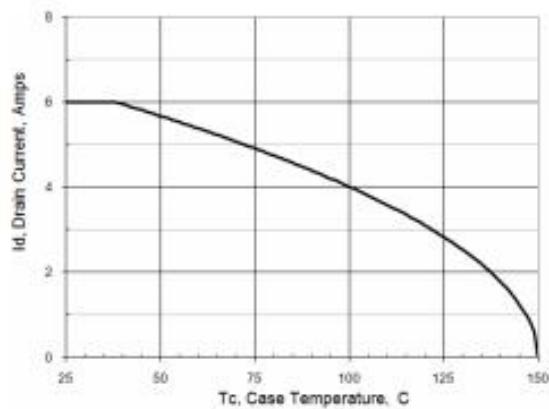


Figure 3 .Maximum Continuous Drain Current vs Case Temperature

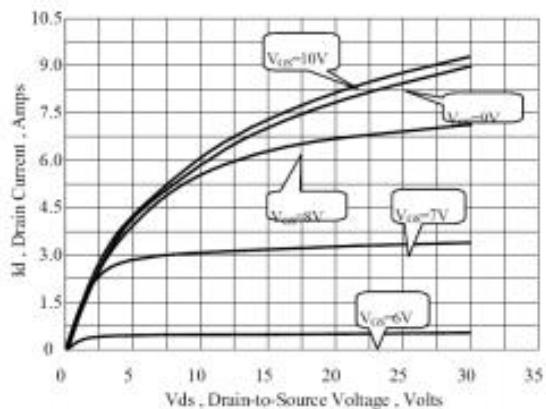


Figure 4 Typical Output Characteristics

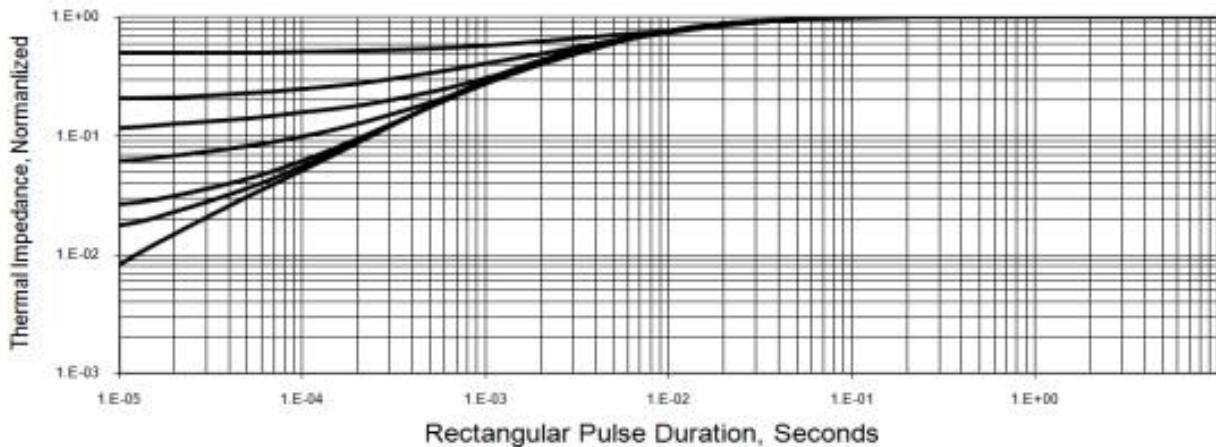


Figure 5. Maximum Transient Thermal Impedance



Typical Characteristics(Cont.)

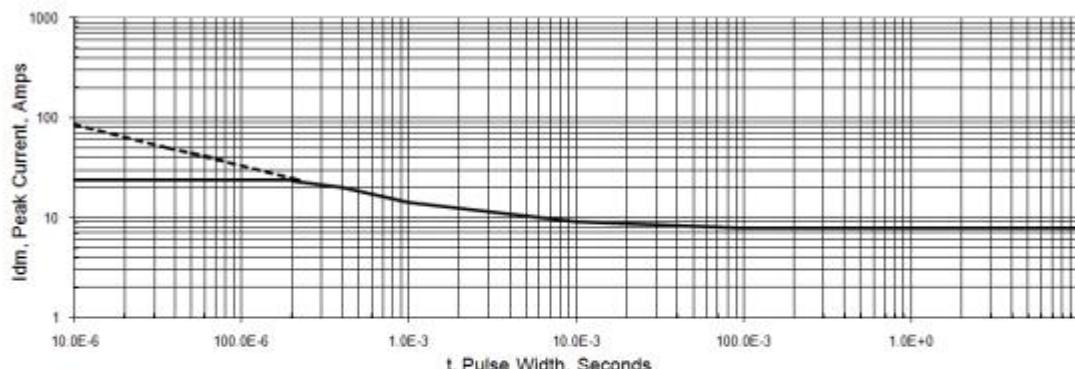


Figure 6. Peak Current Capability

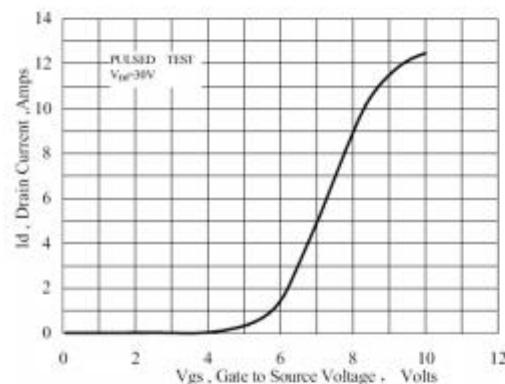


Figure 7 Typical Transfer Characteristics

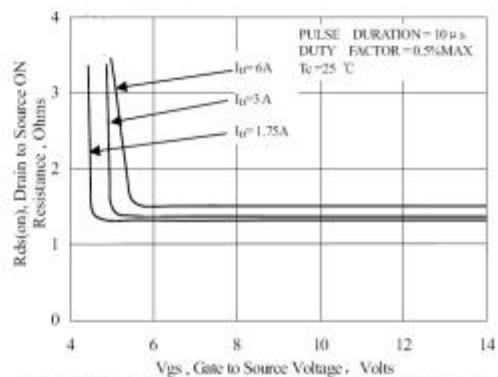


Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

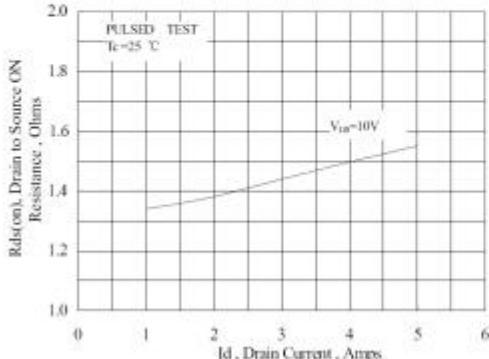


Figure 9 Typical Drain to Source ON Resistance vs Drain Current

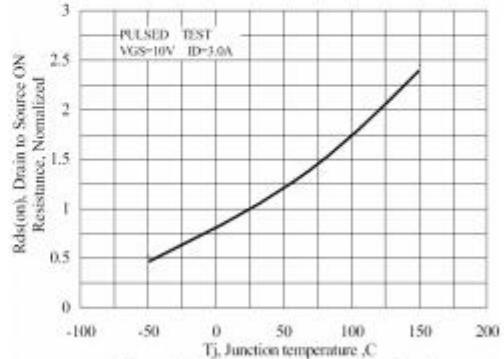


Figure 10 Typical Drian to Source on Resistance vs Junction Temperature



Typical Characteristics(Cont.)

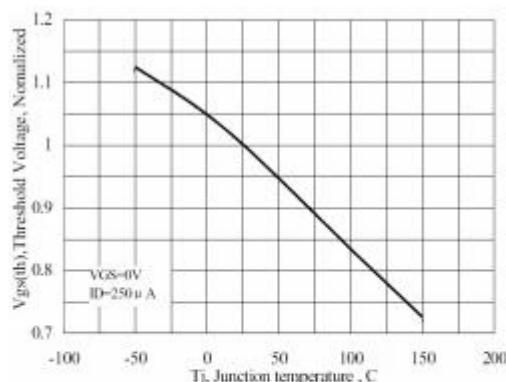


Figure 11 Typical Threshold Voltage vs Junction Temperature

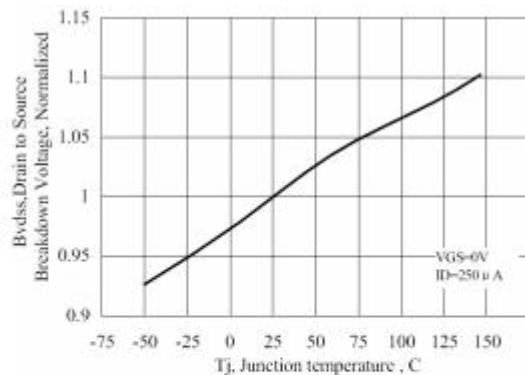


Figure 12 Typical Breakdown Voltage vs Junction Temperat

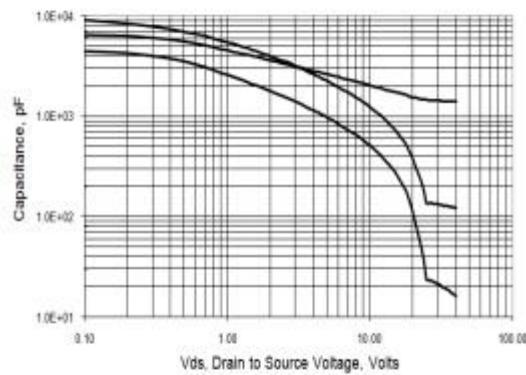


Figure 13. Capacitance vs Vds

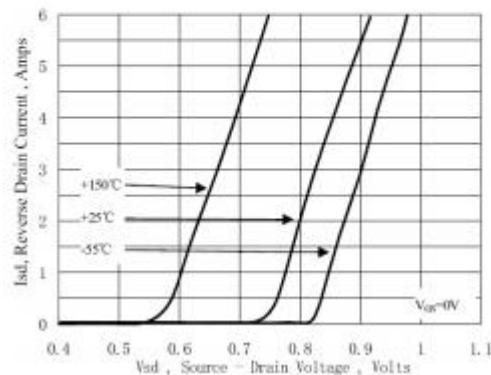


Figure 15 Typical Body Diode Transfer Characteristics

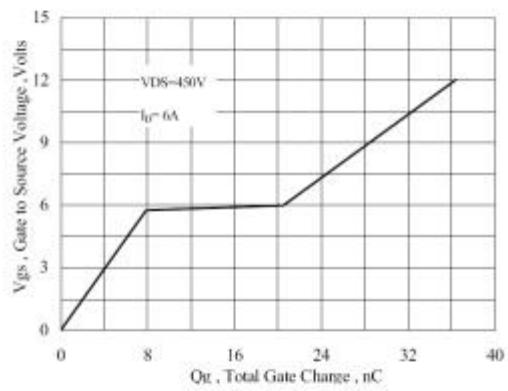


Figure 14 Typical Gate Charge vs Gate to Source Voltage

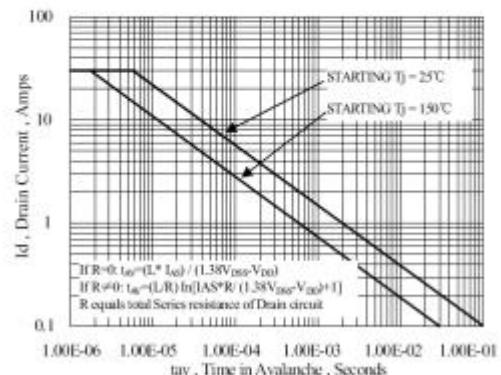
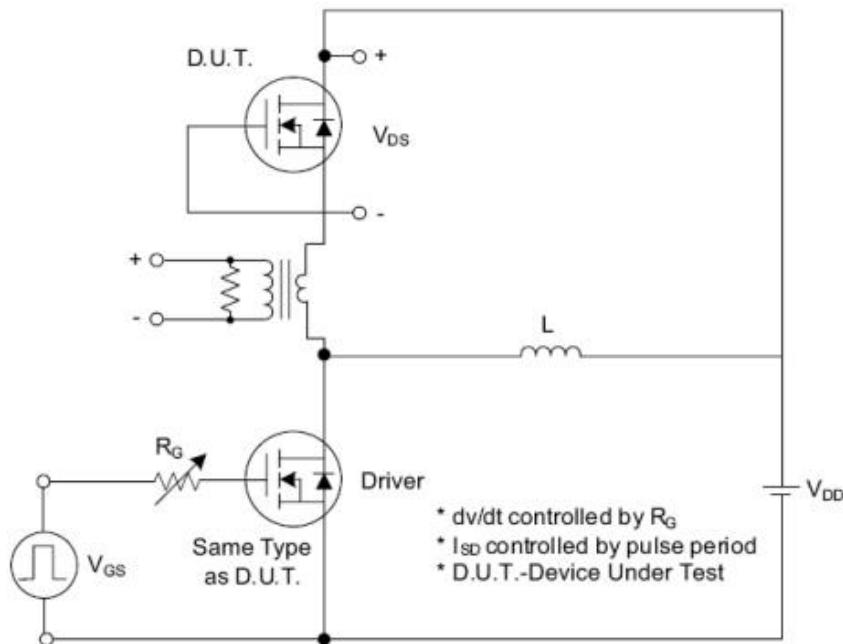
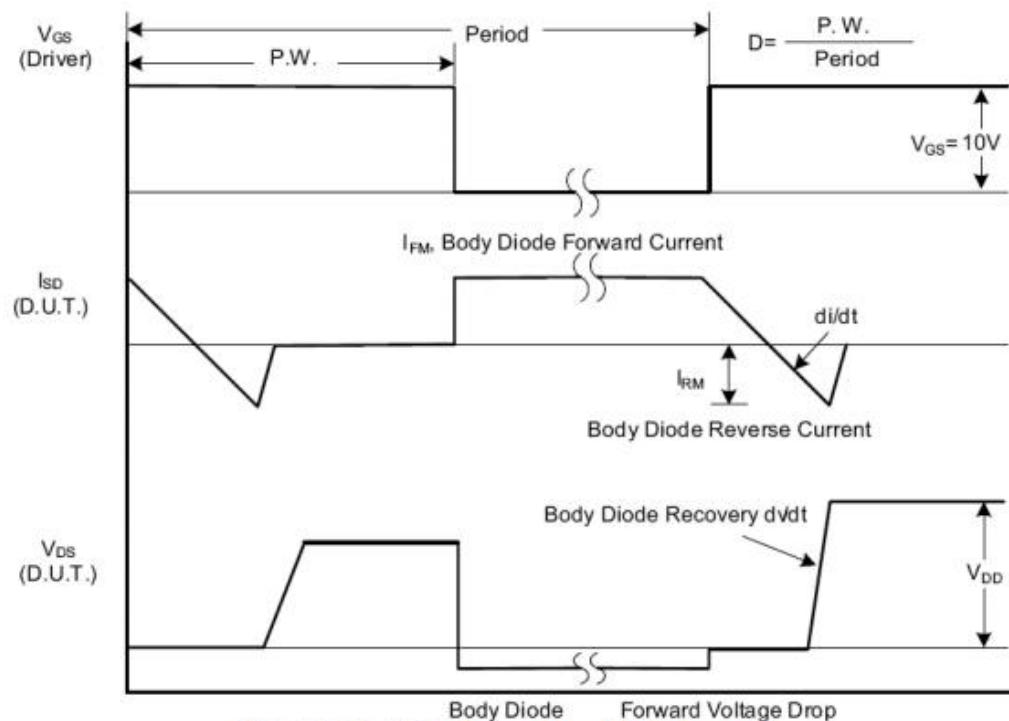


Figure 16 Unclamped Inductive Switching Capability



Test Circuits and Waveforms

Fig. 1.1 Peak Diode Recovery dv/dt Test CircuitFig. 1.2 Peak Diode Recovery dv/dt Waveforms



Test Circuits and Waveforms (Cont.)

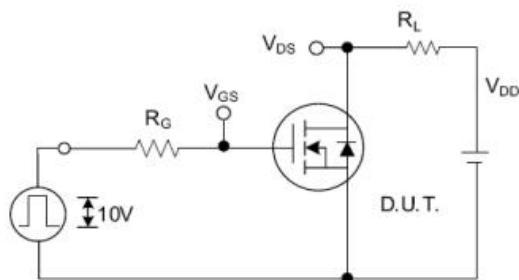


Fig. 2.1 Switching Test Circuit

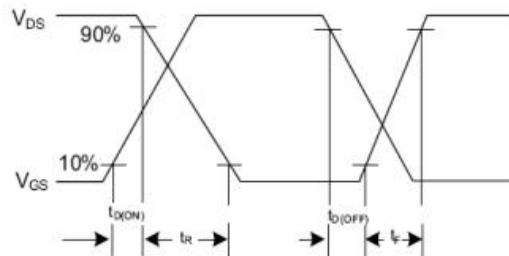


Fig. 2.2 Switching Waveforms

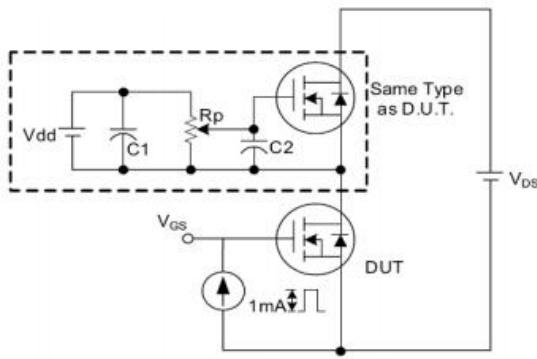


Fig. 3.1 Gate Charge Test Circuit

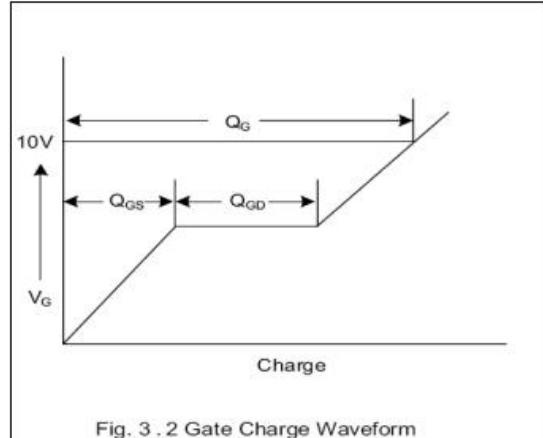


Fig. 3.2 Gate Charge Waveform

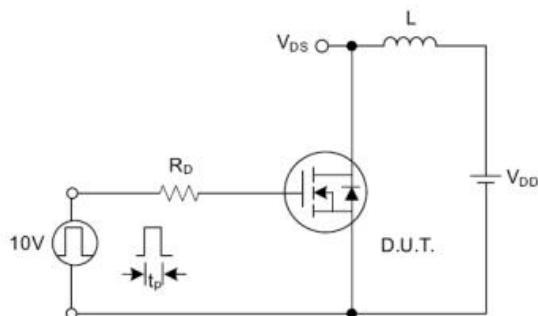


Fig. 4.1 Unclamped Inductive Switching Test Circuit

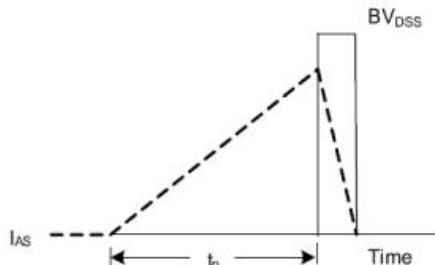


Fig. 4.2 Unclamped Inductive Switching Waveforms